


<b>Search Notes</b>  	<b>Application/Control No.</b>  10588770	<b>Applicant(s)/Patent Under Reexamination</b>  MIYAKE, YOSHIHIRO
	<b>Examiner</b>  THOMAS H STEVENS	<b>Art Unit</b>  2121

SEARCHED			
Class	Subclass	Date	Examiner
700	31	8/27/08	ts
700	210	8/27/08	ts
700	31,210	1/9/09	ts
700	31/210	1/2/2010	ts

SEARCH NOTES		
Search Notes	Date	Examiner
INSPEC: see search report	8/27/08	ts
Google/Google Scholar: see search report	8/27/08	ts
EAST: see search report	1/9/09	ts
EAST: see search report	5/30/2009	ts
EAST: see search report	6/2/2009	ts
IEEE: Y. Miyake	6/2/2009	ts
INSPEC: Y. Miyake	6/2/2009	ts
INSPEC: see search report	6/2/2009	ts
EAST: see search report	1/2/2010	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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